PATENTAND TRADENANCE M22-105 09/214/223 109/214/22	<u></u>												
LIST OF ART CITED BY APPLICANT Wednis LI HINTO DATE GROUP 2816	koo Forter TO	PATENT AND											
FILING DATE DOCUMENTS	R 1 1 2004	7-1											
Cass Subdess Filing Fi		W. C.											
Initial Number	& TRADEMAN	?			U.S. PA	TENT DOCUMENTS							
DV AB 6,153,504 11.40 Shields et al.						Name	Class			ubclass Filing Date If Appropriate			
AC AD AE AF AF AG AII AI AI AI AI AV AN AC Document Number Date Number Date Number Country Class Subdats Transi Yes DV AN 5046186 C206 Japan CYB DV AN 5046186 C206 Japan COUNTRE REFERENCES (foduding Author, Title, Date, Perdaent Pages, Etc.) PV AF Woll, S., Sixon Process, Vol 2 48-49 and 435	DV	AA	5,498,555	5,498,555 03/96 Lin								101	
AC AB AB AB AB AG AG AII AI AI AI AK AL POREIGN PATENT DOCUMENTS Treat/ Ves DV AM 7201716 00/95 Japan DV AN 8046186 02/96 Japan CHER REFERENCES (Including Author, Tide, Date, Perdacet Pages, Etc.) PV AP Wol, S., Sikon Process, Vol. 248-49 and 435	DV	AB	6,153,504	11-00	Shields e	t al.							
AE AF AG AG AII AI AJ AK AL FOREIGN PATENT DOCUMENTS Country Class Subclass Treating the particular of the particular pages, Electory AN 2046126 G296 Japan O'HER REFERENCES (Including Author, Title, Date, Pertinent Pages, Electory AP Wol, S., Silcon Process, Vol 2 48-49 and 435		AC											
AF AG AII AI AI AV AK AL Document Number Date Country Class Subclass Treats Yes DV AM 7201716 0695 Japan DV AN 8046186 0296 Japan DV AO 10-163085 0698 Japan CTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.) PV AP Woll, S., Silcon Process, Vol 2 48-49 and 435		AD											
AG AII AI AI AX AK AL FOREIGN PATENT DOCUMENTS Document Number Date Country Class Subclass Treating Yes Ves DV AM 7201716 08-95 Japan DV AN 8046186 C296 Japan DV AO 10-163025 OG98 Japan OTHER REPERENCES (Including Author, Title, Dute, Pertinent Pages, Etc.) PV AP Woll, S., Silcon Process, Vol. 2 48-49 and 435		AE											
AII AI AI AX AK AL Document Number Date Country Class Subclass Treath Yes DV AM 7201716 08/95 Japan DV AN 8046186 02/96 Japan OTHER REFERENCES (Including Author, Title, Dute, Pertinent Pages, Etc.) PV AP Wol, S., Silcon Process, Vol 248-49 and 435 AC AR		AF											
AI AJ AK AL FOREIGN PATENT DOCUMENTS Document Number Date Country Class Subdass Translives Yes DV AM 7201716 08/95 Japan DV AN 8046186 02/96 Japan OTHER REFERENCES (Including Author, Title, Date, Perdaent Pages, Rec) PV AP Wol, S., Silcon Process., Vol 2 48-49 and 435		AG:											
AI AK FOREIGN PATENT DOCUMENTS Document Number Date Country Class Subdass Transl Yes DV AM 7701716 08/095 Japan I DV AN 8046186 02/06 Japan X DV AO 10-163083 06/98 Japan X OTHER REFERENCES (Including Author, Tide, Date, Pertinent Pages, Etc.) AP Wolf, S., Silcon Process., Vol 248-49 and 435		Ali		1									
AK AL FOREIGN PATENT DOCUMENTS Document Number Date Country Class Subclass Trends Yes		AI		1					\vdash				
Document Date Country Class Subclass Transling		AJ		1									
Document Number Date Country Class Subclass Trendity		AK	-									, i	
Document Number Date Country Class Subclass Transle Yes		AL											
Number Yes			T		FOREIGN	PATENT DOCUMENT	īs		,				
DV			Document Number	Date		Country		Class	Subda		Translation		
DV AN 8046186 02/96 Japan x DV AO 10-163083 06/98 Japan	DV	AM	7201716	08/95	Japan				 		\dashv	No	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.) AP Wolf, S., Silcon Process., Vol 2 48-49 and 435 AO AR									=		十		
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.) AP Wolf, S., Silcon Process., Vol 2 48-49 and 435 AO AR													
AQ AR			(OTHER REFERE		ling Author, Title, Date,	, Pertinent Pages, Etc.)				•		
AR AR	PV	AP	Woll, S., Silicon Pri	Woll, S., Silcon Process., Vot 2 48-49 and 435									
AR AR								· · · · ·		*			
		AO		***************************************									
									<u>. </u>				
EXAMINED OCA (AR											
EVAMINED OCA /													
EXAMINER Souland Date considered 06/17/04	EXAMINER	Sibu	land			DATE CONSIDERED 06/17/04							
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. In copy of this form with next communication to applicant.	*EXAMINER: copy of this for	Initial if re	eference considered, whether	or not citation is in	n conformano	e with MPEP 609; Draw			rmance an	nd not considere	ed. Indu	ade	